Searcn Notes				
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Application/Control No.	Applicant(s)/Patent under Reexamination		
09/974,608	EBIHARA ET AL.	EBIHARA ET AL.	
Examiner	Art Unit	Art Unit	_
Hau H. Nguyen	2628	2628	

SEARCHED			
Class	Subclass	Date	Examiner
345	506, 535, 520	12/18/2006	ZH

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
345	506, 535	12/18/2006	HN	
	520			
see attached				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST Search Notes (updated) 345/ 506, 535, 520 382/ 282 718/ 105	12/18/2006	HN	
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